

Appendix (Additional assessments outside the scope of SCS 0108)**Antenna Parameters with Head TSL at 5200 MHz**

Impedance	53.3 Ω – 4.8 j Ω
Return Loss	-25.0 dB

Antenna Parameters with Head TSL at 5300 MHz

Impedance	48.4 Ω + 2.0 j Ω
Return Loss	-31.6 dB

Antenna Parameters with Head TSL at 5500 MHz

Impedance	47.6 Ω – 2.2 j Ω
Return Loss	-29.5 dB

Antenna Parameters with Head TSL at 5600 MHz

Impedance	55.9 Ω + 0.5 j Ω
Return Loss	-25.1 dB

Antenna Parameters with Head TSL at 5800 MHz

Impedance	50.5 Ω + 4.2 j Ω
Return Loss	-27.5 dB

General Antenna Parameters and Design

Electrical Delay (one direction)	1.207 ns
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After long term use with 100W radiated power, only a slight warming of the dipole near the feedpoint can be measured. The dipole is made of standard semirigid coaxial cable. The center conductor of the feeding line is directly connected to the second arm of the dipole. The antenna is therefore short-circuited for DC-signals. On some of the dipoles, small end caps are added to the dipole arms in order to improve matching when loaded according to the position as explained in the "Measurement Conditions" paragraph. The SAR data are not affected by this change. The overall dipole length is still according to the Standard. No excessive force must be applied to the dipole arms, because they might bend or the soldered connections near the feedpoint may be damaged.

Additional EUT Data

Manufactured by	SPEAG
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System Performance Check Report

Summary

Dipole	Frequency [MHz]	TSL	Power [dBm]
D5GHzV2 - SN1412	5200	HSL	20

Exposure Conditions

Phantom Section, TSL	Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat	10		CW, 0--	5200, 0	5.68	4.51	35.9

Hardware Setup

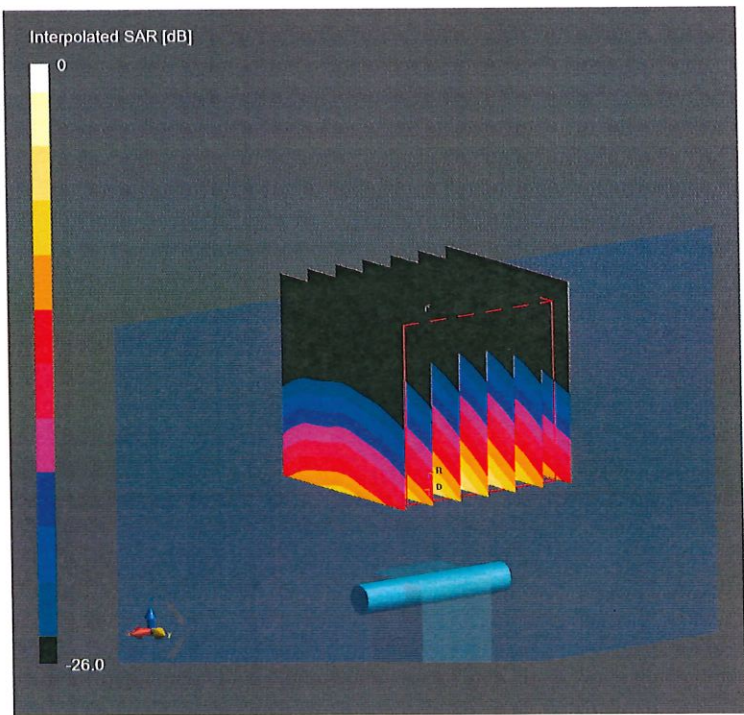
Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
MFP V8.0 Center	HSL, 2024-10-17	EX3DV4 - SN7349, 2024-06-03	DAE4ip Sn1836, 2024-01-10

Scans Setup

	Zoom Scan
Grid Extents [mm]	22 x 22 x 22
Grid Steps [mm]	4.0 x 4.0 x 1.4
Sensor Surface [mm]	1.4
Graded Grid	Yes
Grading Ratio	1.4
MAIA	N/A
Surface Detection	VMS + 6p
Scan Method	Measured

Measurement Results

	Zoom Scan
Date	2024-10-17
psSAR1g [W/Kg]	7.60
psSAR10g [W/Kg]	2.20
Power Drift [dB]	0.00
Power Scaling	Disabled
Scaling Factor [dB]	
TSL Correction	Positive / Negative



0 dB = 30.4 W/Kg

System Performance Check Report

Summary

Dipole	Frequency [MHz]	TSL	Power [dBm]
D5GHzV2 - SN1412	5300	HSL	20

Exposure Conditions

Phantom Section, TSL	Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat	10		CW, 0--	5300, 0	5.45	4.60	35.7

Hardware Setup

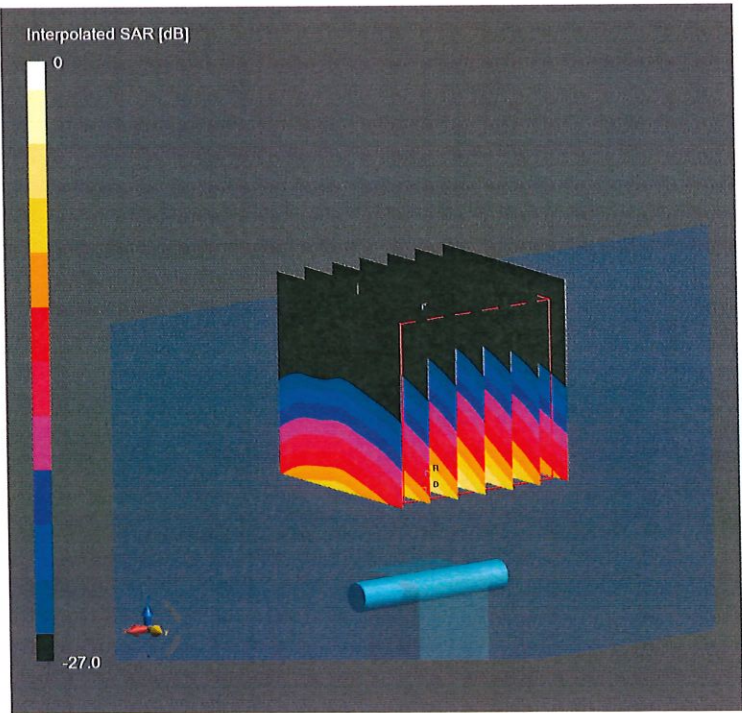
Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
MFP V8.0 Center	HSL, 2024-10-17	EX3DV4 - SN7349, 2024-06-03	DAE4lp Sn1836, 2024-01-10

Scans Setup

	Zoom Scan
Grid Extents [mm]	22 x 22 x 22
Grid Steps [mm]	4.0 x 4.0 x 1.4
Sensor Surface [mm]	1.4
Graded Grid	Yes
Grading Ratio	1.4
MAIA	N/A
Surface Detection	VMS + 6p
Scan Method	Measured

Measurement Results

	Zoom Scan
Date	2024-10-17
psSAR1g [W/Kg]	8.06
psSAR10g [W/Kg]	2.33
Power Drift [dB]	0.00
Power Scaling	Disabled
Scaling Factor [dB]	
TSL Correction	Positive / Negative



0 dB = 33.1 W/Kg

System Performance Check Report

Summary

Dipole	Frequency [MHz]	TSL	Power [dBm]
D5GHzV2 - SN1412	5500	HSL	20

Exposure Conditions

Phantom Section, TSL	Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat	10		CW, 0--	5500, 0	5.07	4.82	35.3

Hardware Setup

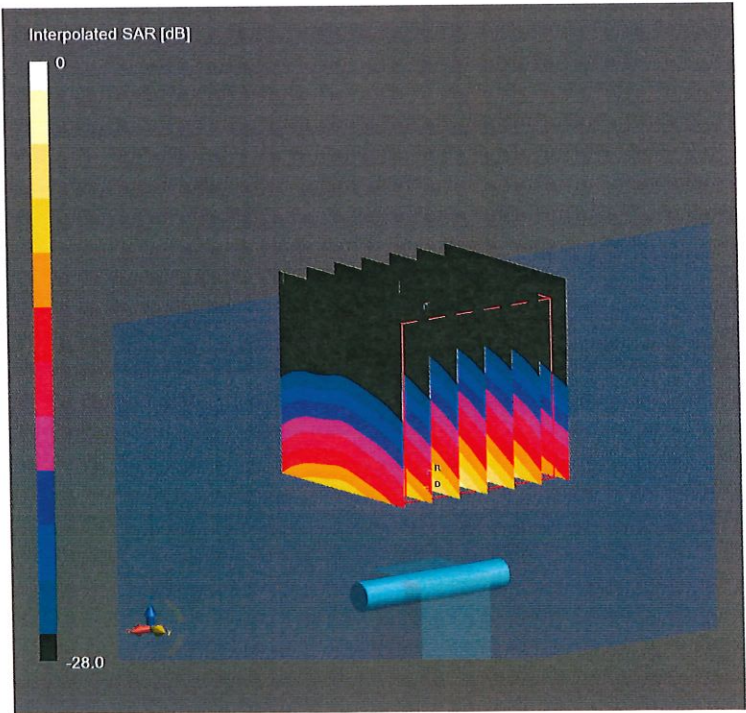
Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
MFP V8.0 Center	HSL, 2024-10-17	EX3DV4 - SN7349, 2024-06-03	DAE4ip Sn1836, 2024-01-10

Scans Setup

	Zoom Scan
Grid Extents [mm]	22 x 22 x 22
Grid Steps [mm]	4.0 x 4.0 x 1.4
Sensor Surface [mm]	1.4
Graded Grid	Yes
Grading Ratio	1.4
MAIA	N/A
Surface Detection	VMS + 6p
Scan Method	Measured

Measurement Results

	Zoom Scan
Date	2024-10-17
psSAR1g [W/Kg]	8.56
psSAR10g [W/Kg]	2.45
Power Drift [dB]	0.00
Power Scaling	Disabled
Scaling Factor [dB]	
TSL Correction	Positive / Negative



0 dB = 36.7 W/Kg

System Performance Check Report

Summary

Dipole	Frequency [MHz]	TSL	Power [dBm]
D5GHzV2 - SN1412	5600	HSL	20

Exposure Conditions

Phantom Section, TSL	Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat	10		CW, 0--	5600, 0	5.03	4.94	35.1

Hardware Setup

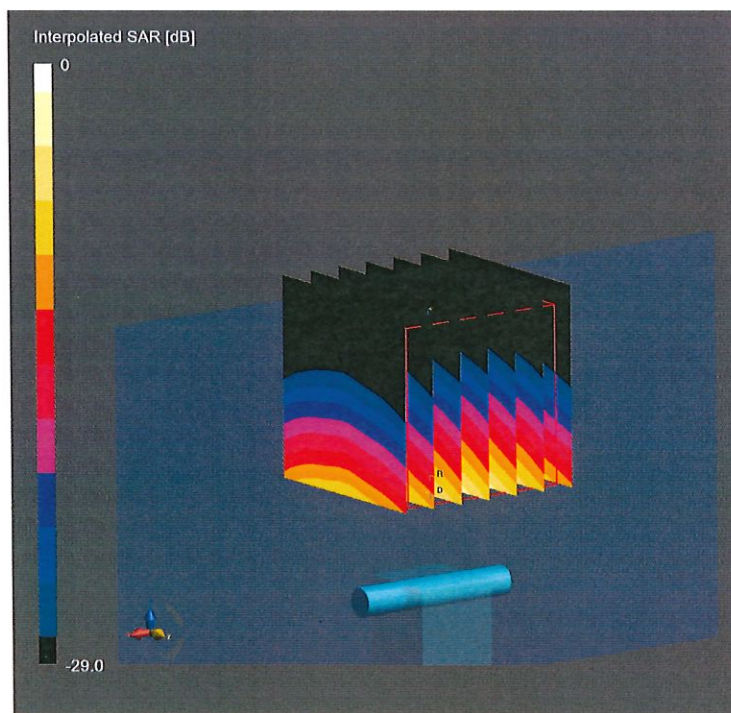
Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
MFP V8.0 Center	HSL, 2024-10-17	EX3DV4 - SN7349, 2024-06-03	DAE4ip Sn1836, 2024-01-10

Scans Setup

	Zoom Scan
Grid Extents [mm]	22 x 22 x 22
Grid Steps [mm]	4.0 x 4.0 x 1.4
Sensor Surface [mm]	1.4
Graded Grid	Yes
Grading Ratio	1.4
MAIA	N/A
Surface Detection	VMS + 6p
Scan Method	Measured

Measurement Results

	Zoom Scan
Date	2024-10-17
psSAR1g [W/Kg]	8.33
psSAR10g [W/Kg]	2.41
Power Drift [dB]	0.00
Power Scaling	Disabled
Scaling Factor [dB]	
TSL Correction	Positive / Negative



System Performance Check Report

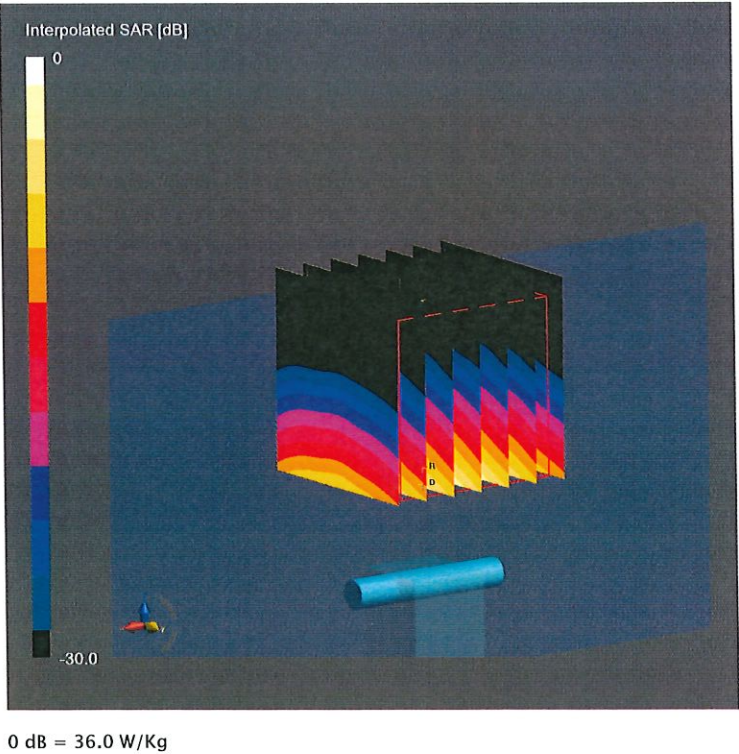
Summary			
Dipole	Frequency [MHz]	TSL	Power [dBm]
D5GHzV2 – SN1412	5800	HSL	20

Exposure Conditions							
Phantom Section, TSL	Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat	10		CW, 0--	5800, 0	5.08	5.15	34.9

Hardware Setup			
Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
MFP V8.0 Center	HSL, 2024-10-17	EX3DV4 – SN7349, 2024-06-03	DAE4ip Sn1836, 2024-01-10

Scans Setup	
	Zoom Scan
Grid Extents [mm]	22 x 22 x 22
Grid Steps [mm]	4.0 x 4.0 x 1.4
Sensor Surface [mm]	1.4
Graded Grid	Yes
Grading Ratio	1.4
MAIA	N/A
Surface Detection	VMS + 6p
Scan Method	Measured

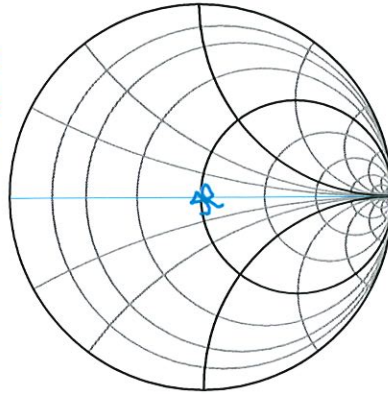
Measurement Results	
	Zoom Scan
Date	2024-10-17
psSAR1g [W/Kg]	7.90
psSAR10g [W/Kg]	2.27
Power Drift [dB]	-0.01
Power Scaling	Disabled
Scaling Factor [dB]	
TSL Correction	Positive / Negative



Impedance Measurement Plot for Head TSL

S11 Smith (R+jX) Scale 1.00

>1	5.200000 GHz	53.331 Ω	-4.787 j Ω
>2	5.300000 GHz	48.405 Ω	2.049 j Ω
>3	5.500000 GHz	47.552 Ω	-2.187 j Ω
>4	5.600000 GHz	55.889 Ω	0.477 j Ω
>5	5.800000 GHz	50.472 Ω	4.191 j Ω



IMPORTANT NOTICE

USAGE OF THE DAE4ip SN: 1921

The DAE unit is a delicate, high precision instrument and requires careful treatment by the user. There are no serviceable parts inside the DAE. Special attention must be given to the following points:

Shipping of the DAE: Before shipping the DAE to SPEAG for calibration, pack the DAE in an antistatic bag. This antistatic bag shall then be packed into a larger box or container which protects the DAE from impacts during transportation. The package shall be marked to indicate that a fragile instrument is inside.

E-Stop Failures: Touch detection may be malfunctioning due to broken magnets in the E-stop. Rough handling of the E-stop may lead to damage of these magnets. Touch and collision errors are often caused by dust and dirt accumulated in the E-stop. To prevent E-stop failure, the customer shall always mount the probe to the DAE carefully and keep the DAE unit in a non-dusty environment if not used for measurements.

Repair: Minor repairs are performed at no extra cost during the calibration. However, SPEAG reserves the right to charge for any repair especially if rough unprofessional handling caused the defect.

DASY Configuration Files: Since the exact values of the DAE input resistances, as measured during the calibration procedure of a DAE unit, are not used by the DASY software, a nominal value of 200 MOhm is given in the corresponding configuration file.

Important Note:

Warranty and calibration is void if the DAE unit is disassembled partly or fully by the Customer.

Important Note:

Never attempt to grease or oil the E-stop assembly. Cleaning and readjusting of the E-stop assembly is allowed by certified SPEAG personnel only and is part of the calibration procedure.

Important Note:

To prevent damage of the DAE probe connector pins, use great care when installing the probe to the DAE. Carefully connect the probe with the connector notch oriented in the mating position. Avoid any rotational movement of the probe body versus the DAE while turning the locking nut of the connector. The same care shall be used when disconnecting the probe from the DAE.



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Multilateral Agreement for the recognition of calibration certificates

Accreditation No.: **SCS 0108**

Client **WSCT**
Shenzhen

Certificate No: **DAE4ip-1921_Sep25**

CALIBRATION CERTIFICATE

Object **DAE4ip - SD 000 D14 AG - SN: 1921**

Calibration procedure(s) **QA CAL-06.v30**
Calibration procedure for the data acquisition electronics (DAE)

Calibration date: **September 04, 2025**

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI).
The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature $(22 \pm 3)^{\circ}\text{C}$ and humidity $< 70\%$.

Calibration Equipment used (M&TE critical for calibration)

Primary Standards	ID #	Cal Date (Certificate No.)	Scheduled Calibration
Keithley Multimeter Type 2001	SN: 0810278	15-Aug-25 (No:43873)	Aug-26
Secondary Standards	ID #	Check Date (in house)	Scheduled Check
Auto DAE Calibration Unit	SE UWS 053 AA 1001	23-Jan-25 (in house check)	In house check: Jan-26
Calibrator Box V2.1	SE UMS 006 AA 1002	23-Jan-25 (in house check)	In house check: Jan-26

	Name	Function	Signature
Calibrated by:	Timo Rott	Laboratory Technician	
Approved by:	Sven Kühn	Technical Manager	

Issued: September 4, 2025

This calibration certificate shall not be reproduced except in full without written approval of the laboratory.



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Accreditation No.: **SCS 0108**

Glossary

DAE data acquisition electronics
Connector angle information used in DASY system to align probe sensor X to the robot coordinate system.

Methods Applied and Interpretation of Parameters

- *DC Voltage Measurement:* Calibration Factor assessed for use in DASY system by comparison with a calibrated instrument traceable to national standards. The figure given corresponds to the full scale range of the voltmeter in the respective range.
- *Connector angle:* The angle of the connector is assessed measuring the angle mechanically by a tool inserted. Uncertainty is not required.
- The following parameters as documented in the Appendix contain technical information as a result from the performance test and require no uncertainty.
 - *DC Voltage Measurement Linearity:* Verification of the Linearity at +10% and -10% of the nominal calibration voltage. Influence of offset voltage is included in this measurement.
 - *Common mode sensitivity:* Influence of a positive or negative common mode voltage on the differential measurement.
 - *Channel separation:* Influence of a voltage on the neighbor channels not subject to an input voltage.
 - *AD Converter Values with inputs shorted:* Values on the internal AD converter corresponding to zero input voltage
 - *Input Offset Measurement:* Output voltage and statistical results over a large number of zero voltage measurements.
 - *Input Offset Current:* Typical value for information; Maximum channel input offset current, not considering the input resistance.
 - *Input resistance:* Typical value for information: DAE input resistance at the connector, during internal auto-zeroing and during measurement.
 - *Low Battery Alarm Voltage:* Typical value for information. Below this voltage, a battery alarm signal is generated.
 - *Power consumption:* Typical value for information. Supply currents in various operating modes.

DC Voltage Measurement

A/D - Converter Resolution nominal

High Range: 1LSB = 6.1 μ V, full range = -100...+300 mV

Low Range: 1LSB = 61nV, full range = -1.....+3mV

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

Calibration Factors	X	Y	Z
High Range	405.339 $\pm$ 0.02% (k=2)	405.748 $\pm$ 0.02% (k=2)	405.675 $\pm$ 0.02% (k=2)
Low Range	3.99724 $\pm$ 1.50% (k=2)	3.98942 $\pm$ 1.50% (k=2)	4.00806 $\pm$ 1.50% (k=2)

Connector Angle

Connector Angle to be used in DASY system	77.5 ° $\pm$ 1 °
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Appendix (Additional assessments outside the scope of SCS0108)

1. DC Voltage Linearity

High Range		Reading (μV)	Difference (μV)	Error (%)
Channel X	+ Input	200003.68	1.60	0.00
Channel X	+ Input	20010.61	2.62	0.01
Channel X	- Input	-19994.77	2.48	-0.01
Channel Y	+ Input	200004.42	1.84	0.00
Channel Y	+ Input	20007.69	-0.26	-0.00
Channel Y	- Input	-19997.23	0.16	-0.00
Channel Z	+ Input	200002.59	0.37	0.00
Channel Z	+ Input	20007.41	-0.39	-0.00
Channel Z	- Input	-19998.21	-0.69	0.00

Low Range		Reading (μV)	Difference (μV)	Error (%)
Channel X	+ Input	2007.75	1.47	0.07
Channel X	+ Input	207.25	0.72	0.35
Channel X	- Input	-193.00	0.26	-0.14
Channel Y	+ Input	2007.15	0.90	0.04
Channel Y	+ Input	206.28	-0.23	-0.11
Channel Y	- Input	-194.22	-0.94	0.49
Channel Z	+ Input	2006.80	0.62	0.03
Channel Z	+ Input	205.63	-0.68	-0.33
Channel Z	- Input	-195.01	-1.56	0.81

2. Common mode sensitivity

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	Common mode Input Voltage (mV)	High Range Average Reading (μV)	Low Range Average Reading (μV)
Channel X	200	0.47	-1.00
	- 200	1.61	0.55
Channel Y	200	2.60	1.95
	- 200	-3.09	-3.32
Channel Z	200	-16.60	-16.30
	- 200	14.45	14.40

3. Channel separation

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	Input Voltage (mV)	Channel X (μV)	Channel Y (μV)	Channel Z (μV)
Channel X	200	-	0.13	-1.91
Channel Y	200	4.24	-	1.29
Channel Z	200	8.02	1.85	-

4. AD-Converter Values with inputs shorted

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	High Range (LSB)	Low Range (LSB)
Channel X	15794	15541
Channel Y	15816	15550
Channel Z	15914	15220

5. Input Offset Measurement

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

Input 10M Ω

	Average (μ V)	min. Offset (μ V)	max. Offset (μ V)	Std. Deviation (μ V)
Channel X	0.24	-0.42	0.81	0.27
Channel Y	0.15	-1.17	0.96	0.37
Channel Z	-0.41	-1.33	0.68	0.34

6. Input Offset Current

Nominal Input circuitry offset current on all channels: <25fA

7. Input Resistance (Typical values for information)

	Zeroing (kOhm)	Measuring (MOhm)
Channel X	200	200
Channel Y	200	200
Channel Z	200	200

8. Low Battery Alarm Voltage (Typical values for information)

Typical values	Alarm Level (VDC)
Supply (+ Vcc)	+7.9
Supply (- Vcc)	-7.6

9. Power Consumption (Typical values for information)

Typical values	Switched off (mA)	Stand by (mA)	Transmitting (mA)
Supply (+ Vcc)	+0.01	+6	+14
Supply (- Vcc)	-0.01	-8	-9



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Multilateral Agreement for the recognition of calibration certificates

Accreditation No.: SCS 0108

Client

WSCT
Shenzhen

Certificate No.

EX-7951_Sep25

CALIBRATION CERTIFICATE

Object

EX3DV4 - SN:7951

Calibration procedure(s)

QA CAL-01.v10, QA CAL-12.v10, QA CAL-14.v7, QA CAL-23.v6,
QA CAL-25.v8
Calibration procedure for dosimetric E-field probes

Calibration date

September 10, 2025

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI).
The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature $(22 \pm 3)^\circ\text{C}$ and humidity $< 70\%$.

Calibration Equipment used (M&TE critical for calibration)

Primary Standards	ID	Calibration Date (Certificate No.)	Sched. Cal.
Power Sensor R&S NRP-33T	SN: 100967	30-Apr-25 (No. 1020-300791789)	Apr-26
N-type mismatch combination	SN: L1119	26-Mar-25 (No. 217-04292)	Mar-26
OCP DAK-12	SN: 1016	24-Sept-24 (No. OCP-DAK12-1016_Sep24)	Sep-25
OCP DAK-3.5	SN: 1249	23-Sept-24 (No. OCP-DAK3.5-1249_Sep24)	Sep-25
Reference Probe EX3DV4	SN: 7349	10-Jan-25 (No. EX3-7349_Jan25)	Jan-26
DAE4	SN: 1301	07-Nov-24 (No. DAE4-1301_Nov24)	Nov-25

Secondary Standards	ID	Check Date (in house)	Sched. Check
ACAP 2020 Setup 1	SN: L1404	30-Sept-24 (No. Report_ACAP2020E-Cave_20240930s)	Sep-25
OCP DAK-12	SN: 1029	27-Feb-25 (No. OCP-DAK12-1029_Feb25)	Feb-26
OCP DAK-3.5	SN: 1336	09-Dec-24 (No. OCP-DAK3.5-1336_Dec24)	Dec-25

	Name	Function	Signature
Calibrated by	Jeffrey Katzman	Laboratory Technician	
Approved by	Sven Kühn	Technical Manager	

Issued: September 10, 2025

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Calibration Laboratory of

Schmid & Partner
Engineering AG

Zeughausstrasse 43, 8004 Zurich, Switzerland



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Accreditation No.: SCS 0108

Glossary

TSL	tissue simulating liquid
NORM _{x,y,z}	sensitivity in free space
ConvF	sensitivity in TSL / NORM _{x,y,z}
DCP	diode compression point
CF	crest factor (1/duty_cycle) of the RF signal
A, B, C, D	modulation dependent linearization parameters
Polarization φ	φ rotation around probe axis
Polarization ϑ	ϑ rotation around an axis that is in the plane normal to probe axis (at measurement center), i.e., $\vartheta = 0$ is normal to probe axis
Connector Angle	information used in DASY system to align probe sensor X to the robot coordinate system

Calibration is Performed According to the Following Standards:

- IEC/IEEE 62209-1528, "Measurement Procedure For The Assessment Of Specific Absorption Rate Of Human Exposure To Radio Frequency Fields From Hand-Held And Body-Worn Wireless Communication Devices – Part 1528: Human Models, Instrumentation And Procedures (Frequency Range of 4 MHz to 10 GHz)", October 2020.
- KDB 865664, "SAR Measurement Requirements for 100 MHz to 6 GHz"

Methods Applied and Interpretation of Parameters:

- NORM_{x,y,z}**: Assessed for E-field polarization $\vartheta = 0$ ($f \leq 900$ MHz in TEM-cell; $f > 1800$ MHz: R22 waveguide). NORM_{x,y,z} are only intermediate values, i.e., the uncertainties of NORM_{x,y,z} does not affect the E²-field uncertainty inside TSL (see below ConvF).
- NORM(f)_{x,y,z}** = NORM_{x,y,z} * frequency_response (see Frequency Response Chart). This linearization is implemented in DASY4 software versions later than 4.2. The uncertainty of the frequency response is included in the stated uncertainty of ConvF.
- DCP_{x,y,z}**: DCP are numerical linearization parameters assessed based on the data of power sweep with CW signal. DCP does not depend on frequency nor media.
- PAR**: PAR is the Peak to Average Ratio that is not calibrated but determined based on the signal characteristics
- A_{x,y,z}; B_{x,y,z}; C_{x,y,z}; D_{x,y,z}; VR_{x,y,z}**: A, B, C, D are numerical linearization parameters assessed based on the data of power sweep for specific modulation signal. The parameters do not depend on frequency nor media. VR is the maximum calibration range expressed in RMS voltage across the diode.
- ConvF and Boundary Effect Parameters**: Assessed in flat phantom using E-field (or Temperature Transfer Standard for $f \leq 800$ MHz) and inside waveguide using analytical field distributions based on power measurements for $f > 800$ MHz. The same setups are used for assessment of the parameters applied for boundary compensation (alpha, depth) of which typical uncertainty values are given. These parameters are used in DASY4 software to improve probe accuracy close to the boundary. The sensitivity in TSL corresponds to NORM_{x,y,z} * ConvF whereby the uncertainty corresponds to that given for ConvF. A frequency dependent ConvF is used in DASY version 4.4 and higher which allows extending the validity from ± 50 MHz to ± 100 MHz.
- Spherical isotropy (3D deviation from isotropy)**: in a field of low gradients realized using a flat phantom exposed by a patch antenna.
- Sensor Offset**: The sensor offset corresponds to the offset of virtual measurement center from the probe tip (on probe axis). No tolerance required.
- Connector Angle**: The angle is assessed using the information gained by determining the NORM_x (no uncertainty required).

Parameters of Probe: EX3DV4 - SN:7951

Basic Calibration Parameters

	Sensor X	Sensor Y	Sensor Z	Unc ($k = 2$)
Norm ($\mu\text{V}/(\text{V}/\text{m})^2$) ^A	0.63	0.62	0.55	$\pm 10.1\%$
DCP (mV) ^B	102.8	103.1	105.0	$\pm 4.7\%$

Calibration Results for Modulation Response

UID	Communication System Name		A dB	B $\text{dB}/\sqrt{\mu\text{V}}$	C	D dB	VR mV	Max dev.	Max Unc ^E $k = 2$
0	Continuous Wave	X	0.00	0.00	1.00	0.00	121.7	$\pm 1.0\%$	$\pm 4.7\%$
		Y	0.00	0.00	1.00		145.0		
		Z	0.00	0.00	1.00		138.7		
10352	Pulse (D=10%, T=5 ms)	X	0.46	68.52	17.98	10.00	23.0	$\pm 1.9\%$	$\pm 9.6\%$
		Y	0.30	70.00	18.96		23.0		
		Z	0.21	60.04	14.79		22.0		
10353	Pulse (D=20%, T=5 ms)	X	0.43	71.53	18.03	6.99	45.0	$\pm 1.5\%$	$\pm 9.6\%$
		Y	0.27	73.01	19.01		46.0		
		Z	0.19	63.05	14.82		45.0		
10354	Pulse (D=40%, T=5 ms)	X	0.41	74.54	18.08	3.98	90.0	$\pm 1.3\%$	$\pm 9.6\%$
		Y	0.25	76.02	19.06		91.0		
		Z	0.18	66.06	14.85		90.0		
10355	Pulse (D=60%, T=5 ms)	X	0.39	76.30	18.11	2.22	135.0	$\pm 1.3\%$	$\pm 9.6\%$
		Y	0.24	77.78	19.08		137.0		
		Z	0.17	67.82	14.87		134.0		
10387	Random (BW=1 MHz, MOD=QPSK)	X	0.00	73.42	19.33	0.12	105.0	$\pm 1.6\%$	$\pm 9.6\%$
		Y	0.00	74.90	20.21		107.0		
		Z	0.01	64.94	15.86		105.0		
10388	Random (BW=10 MHz, MOD=QPSK)	X	1.62	73.30	16.90	0.00	111.0	$\pm 2.6\%$	$\pm 9.6\%$
		Y	1.59	74.78	17.62		113.0		
		Z	0.62	64.82	14.04		111.0		
10396	Random (BW=100 kHz, MOD=64QAM)	X	0.01	72.25	21.05	1.80	78.0	$\pm 5.1\%$	$\pm 9.6\%$
		Y	0.03	73.73	21.65		79.0		
		Z	0.00	63.76	17.04		77.0		
10399	Random (BW=40 MHz, MOD=64QAM)	X	3.63	72.25	16.74	0.00	103.0	$\pm 3.7\%$	$\pm 9.6\%$
		Y	3.73	73.73	17.46		105.0		
		Z	1.66	63.76	13.22		103.0		
10414	Random (BW=40 MHz, HIGH PAR)	X	4.48	69.98	16.73	0.00	76.0	$\pm 1.7\%$	$\pm 9.6\%$
		Y	4.64	71.46	17.46		77.0		
		Z	2.02	61.50	13.14		75.0		

Note: For details on UID parameters see Appendix

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor $k=2$, which for a normal distribution corresponds to a coverage probability of approximately 95%.

^A The uncertainties of Norm X,Y,Z do not affect the E^2 -field uncertainty inside TSL (see Pages 5 and 6).

^B Linearization parameter uncertainty for maximum specified field strength.

^E Uncertainty is determined using the max. deviation from linear response applying rectangular distribution and is expressed for the square of the field value.

Parameters of Probe: EX3DV4 - SN:7951

Sensor Model Parameters

	C1 fF	C2 fF	α V ⁻¹	T1 ms V ⁻²	T2 ms V ⁻¹	T3 ms	T4 V ⁻²	T5 V ⁻¹	T6
x	11.9	88.22	35.05	4.32	0.00	4.90	0.59	0.00	1.00
y	11.1	83.34	35.67	1.23	0.00	4.90	0.49	0.00	1.00
z	9.2	68.06	34.66	2.58	0.00	4.90	0.64	0.00	1.00

Other Probe Parameters

Sensor Arrangement	Triangular
Connector Angle	83.0°
Mechanical Surface Detection Mode	enabled
Optical Surface Detection Mode	disabled
Probe Overall Length	337 mm
Probe Body Diameter	12 mm
Tip Length	9 mm
Tip Diameter	2.5 mm
Probe Tip to Sensor X Calibration Point	1 mm
Probe Tip to Sensor Y Calibration Point	1 mm
Probe Tip to Sensor Z Calibration Point	1 mm
Recommended Measurement Distance from Surface	1.4 mm

Note: Measurement distance from surface can be increased to 3–4 mm for an *Area Scan* job.

Parameters of Probe: EX3DV4 - SN:7951

Calibration Parameter Determined in HSL

f (MHz) ^C	Relative Permittivity ^F	Conductivity ^F (S/m)	ConvF X	ConvF Y	ConvF Z	Alpha ^G	Depth ^G (mm)	Unc ^H (k = 2)
750	41.9	0.89	9.61	9.49	9.67	0.35	1.27	±11.0%
835	41.5	0.90	9.48	9.36	9.54	0.35	1.27	±11.0%
1750	40.1	1.37	7.84	7.75	7.89	0.35	1.27	±11.0%
1900	40.0	1.40	7.69	7.60	7.74	0.35	1.27	±11.0%
2000	40.0	1.40	7.64	7.54	7.68	0.35	1.27	±11.0%
2300	39.5	1.67	7.52	7.43	7.57	0.35	1.27	±11.0%
2450	39.2	1.80	7.08	6.99	7.13	0.35	1.27	±11.0%
2600	39.0	1.96	7.27	7.18	7.32	0.35	1.27	±11.0%
3300	38.2	2.71	6.51	6.43	6.55	0.35	1.27	±13.1%
3500	37.9	2.91	6.58	6.50	6.62	0.35	1.27	±13.1%
3700	37.7	3.12	6.45	6.37	6.49	0.35	1.27	±13.1%
3900	37.5	3.32	6.43	6.35	6.47	0.35	1.27	±13.1%
4100	37.2	3.53	6.29	6.22	6.33	0.35	1.27	±13.1%
4200	37.1	3.63	6.24	6.16	6.27	0.35	1.27	±13.1%
4400	36.9	3.84	6.05	5.97	6.08	0.35	1.27	±13.1%
4600	36.7	4.04	5.94	5.86	5.98	0.34	1.27	±13.1%
4800	36.4	4.25	6.10	6.03	6.14	0.34	1.27	±13.1%
4950	36.3	4.40	6.04	5.97	6.08	0.33	1.27	±13.1%
5200	36.0	4.66	5.70	5.62	5.73	0.31	1.27	±13.1%
5300	35.9	4.76	5.55	5.47	5.58	0.30	1.27	±13.1%
5500	35.6	4.96	5.29	5.22	5.33	0.28	1.27	±13.1%
5600	35.5	5.07	5.15	5.08	5.18	0.28	1.27	±13.1%
5800	35.3	5.27	5.16	5.09	5.19	0.26	1.27	±13.1%

^C Frequency validity above 300 MHz of ±100 MHz only applies for DASY v4.4 and higher (see Page 2), else it is restricted to ±50 MHz. The uncertainty is the RSS of the ConvF uncertainty at calibration frequency and the uncertainty for the indicated frequency band. Frequency validity below 300 MHz is ±10, 25, 40, 50 and 70 MHz for ConvF assessments at 30, 64, 128, 150 and 220 MHz respectively. Validity of ConvF assessed at 6 MHz is 4–9 MHz, and ConvF assessed at 13 MHz is 9–19 MHz. Above 5 GHz frequency validity can be extended to ±110 MHz.

^F The probes are calibrated using tissue simulating liquids (TSL) that deviate for ϵ and σ by less than ±5% from the target values (typically better than ±3%) and are valid for TSL with deviations of up to ±10% if SAR correction is applied.

^G Alpha/Depth are determined during calibration. SPEAG warrants that the remaining deviation due to the boundary effect after compensation is always less than ±1% for frequencies below 3 GHz and below ±2% for frequencies between 3–6 GHz at any distance larger than half the probe tip diameter from the boundary.

^H The stated uncertainty is the total calibration uncertainty ($k = 2$) of Norm-ConvF. This is equivalent to the uncertainty component with the symbol CF in Table 9 of IEC/IEEE 62209-1528:2020.

Parameters of Probe: EX3DV4 - SN:7951

Calibration Parameter Determined in HSL

f (MHz) ^C	Relative Permittivity ^F	Conductivity ^F (S/m)	ConvF X	ConvF Y	ConvF Z	Alpha ^G	Depth ^G (mm)	Unc ^H (k = 2)
6500	34.5	6.07	5.28	5.21	5.31	0.20	1.27	±18.6%

^C Frequency validity is -600/+700 MHz at 6.5 GHz, ±700 MHz at or above 7 GHz, and ±150 MHz at 9.85 GHz. The uncertainty is the RSS of the ConvF uncertainty at calibration frequency and the uncertainty for the indicated frequency band.

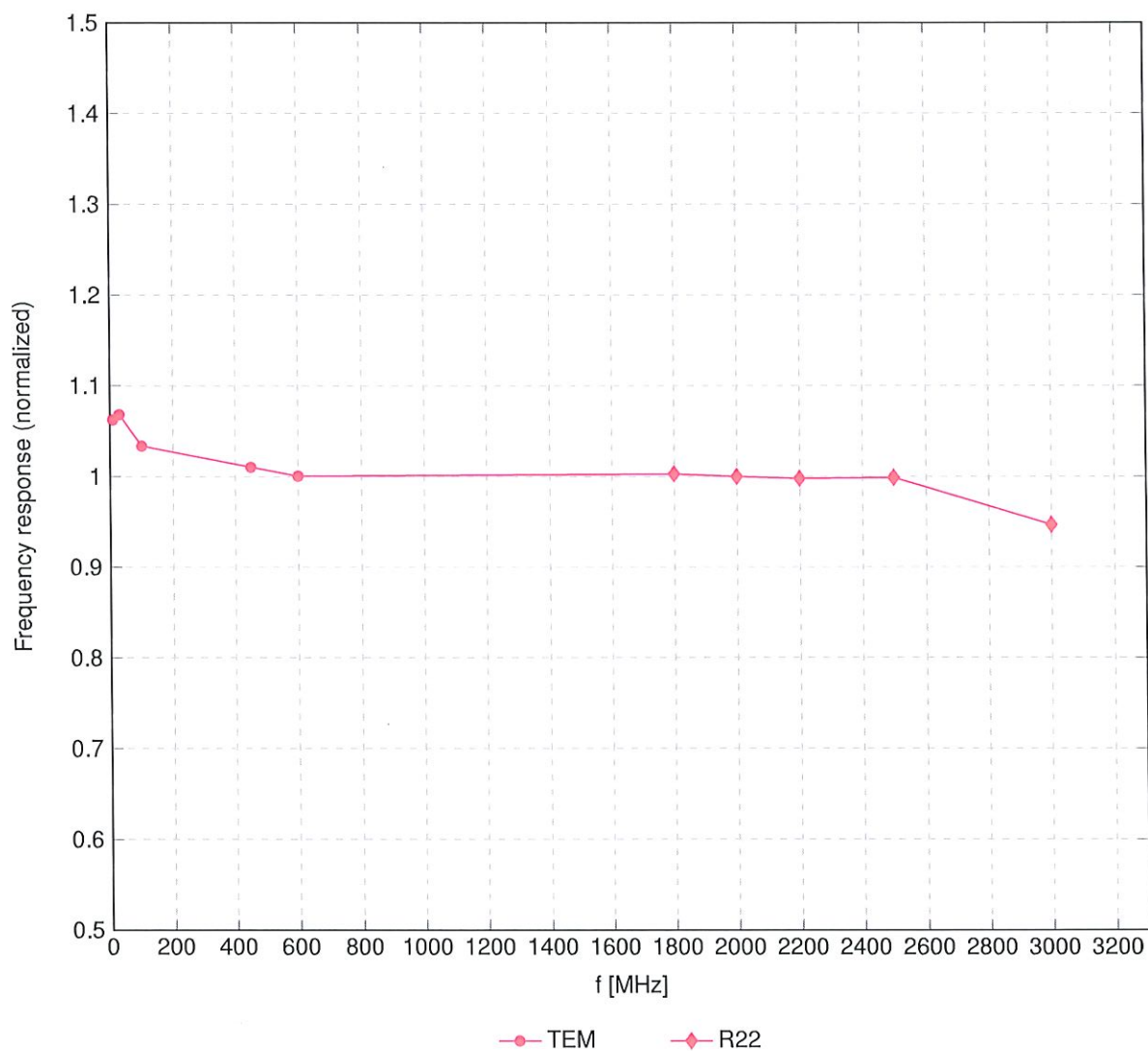
^F The probes are calibrated using tissue simulating liquids (TSL) that deviate for ϵ and σ by less than ±10% from the target values (typically better than ±6%) and are valid for TSL with deviations of up to ±10%.

^G Alpha/Depth are determined during calibration. SPEAG warrants that the remaining deviation due to the boundary effect after compensation is always less than ±1% for frequencies below 3 GHz; below ±2% for frequencies between 3–6 GHz; and below ±4% for frequencies between 6–10 GHz at any distance larger than half the probe tip diameter from the boundary.

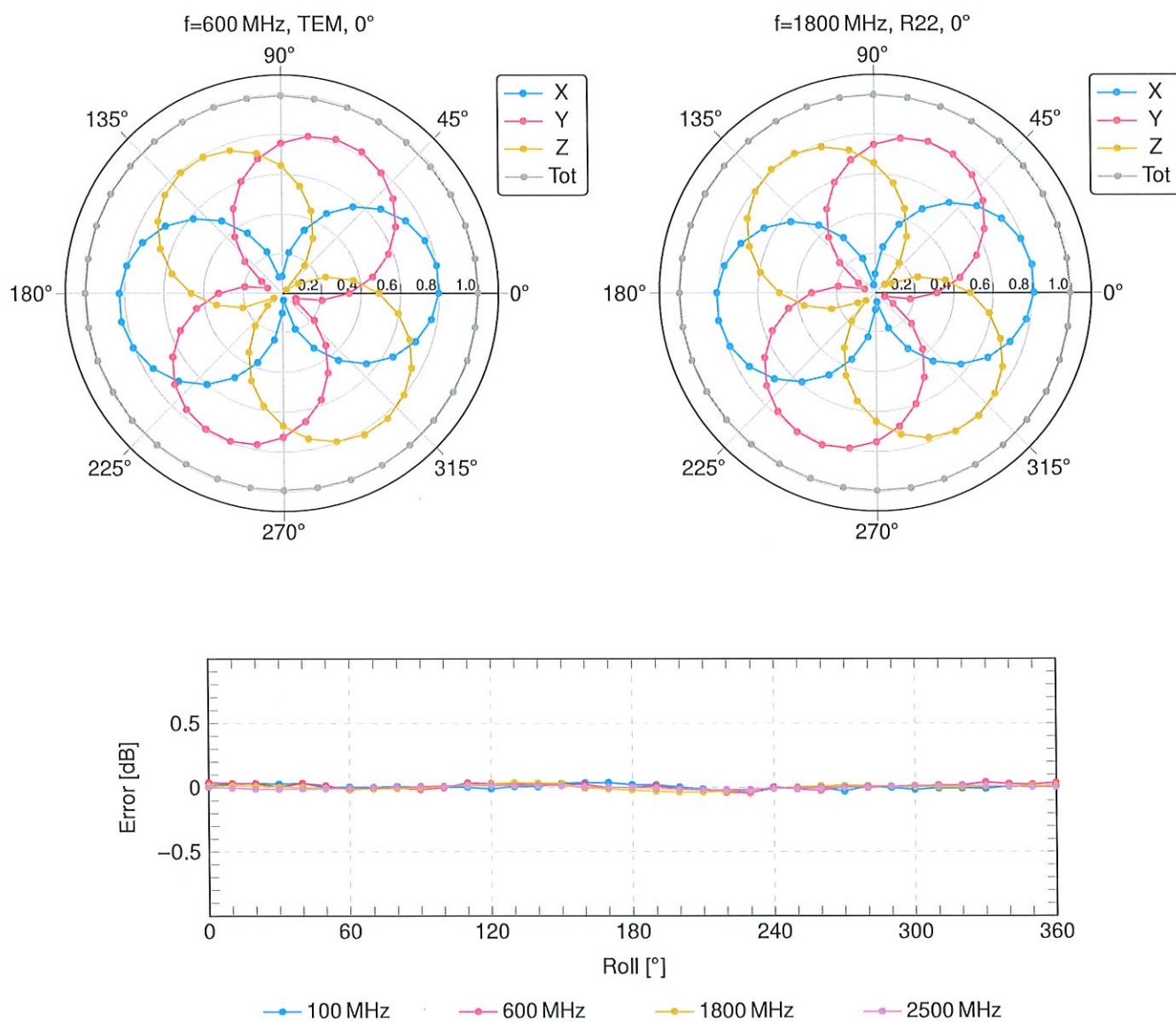
^H The stated uncertainty is the total calibration uncertainty (k = 2) of Norm-ConvF. This is equivalent to the uncertainty component with the symbol CF in Table 9 of IEC/IEEE 62209-1528:2020.

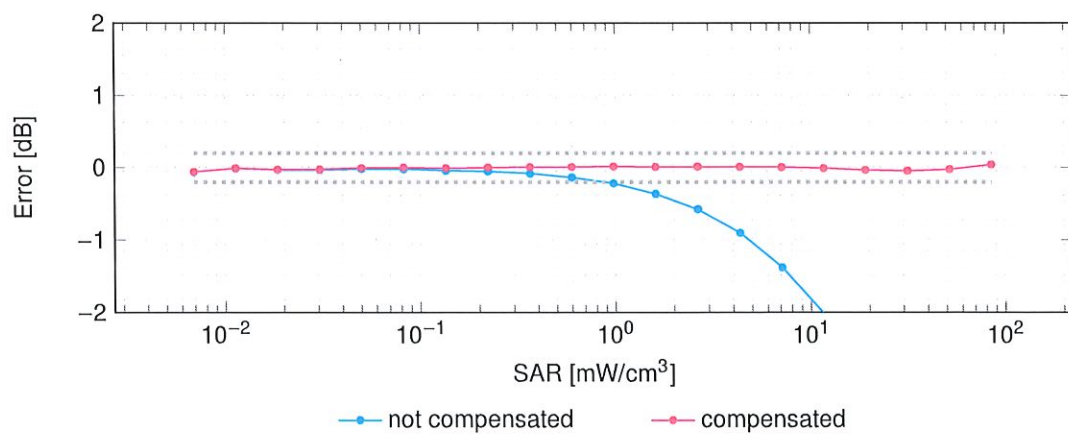
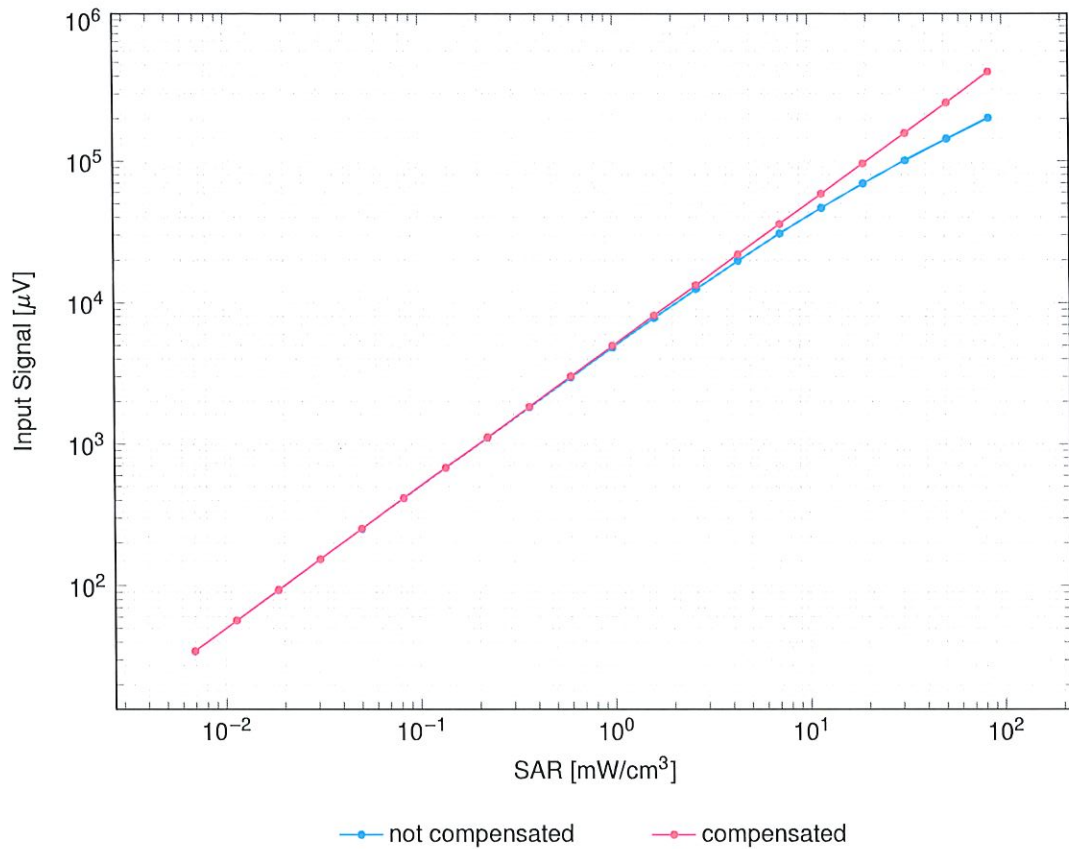
Frequency Response of E-Field

(TEM-Cell:ifi110 EXX, Waveguide:R22)

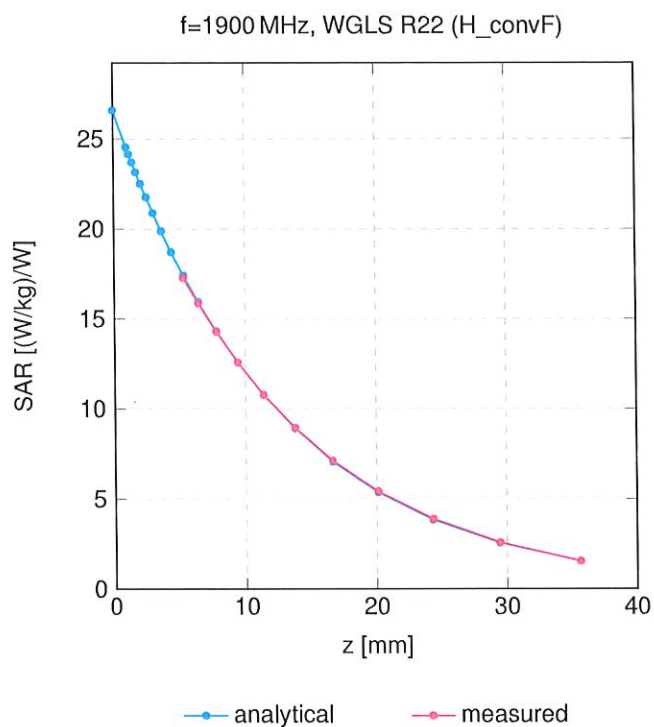


Uncertainty of Frequency Response of E-field: $\pm 6.3\%$ ($k=2$)

Receiving Pattern (ϕ), $\vartheta = 0^\circ$ Uncertainty of Axial Isotropy Assessment: $\pm 0.5\%$ ($k=2$)

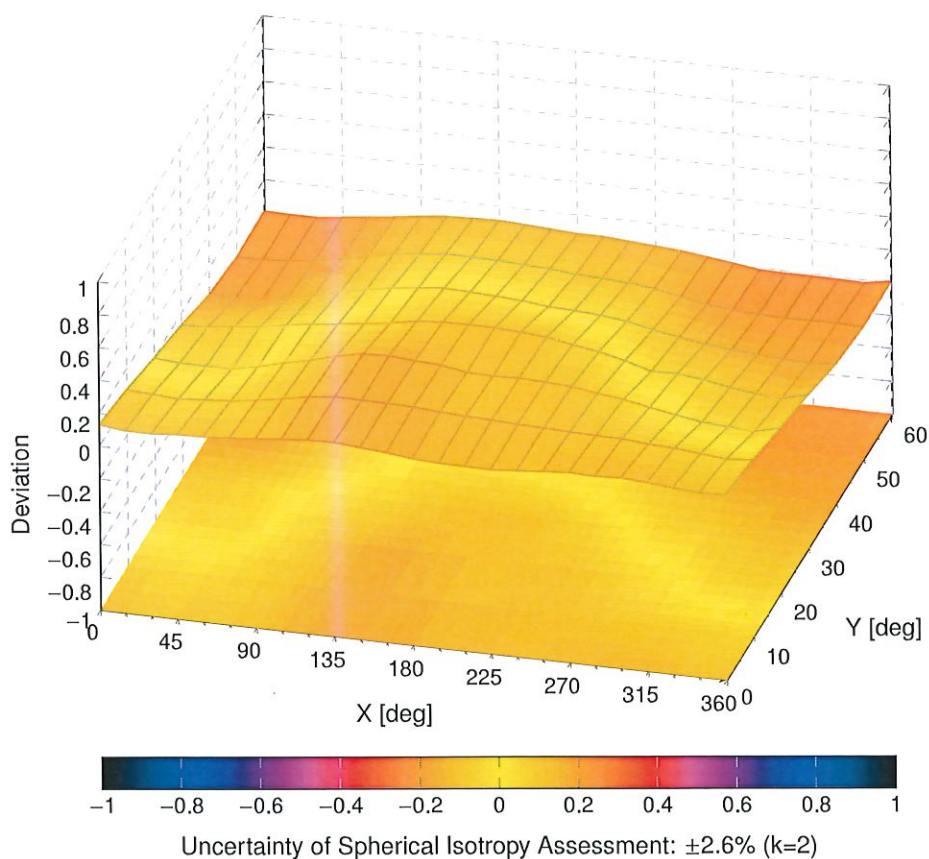
Dynamic Range $f(\text{SAR}_{\text{HSL}})$ (TEM cell, $f_{\text{eval}} = 1900 \text{ MHz}$)Uncertainty of Linearity Assessment: $\pm 0.6\%$ ($k=2$)

Conversion Factor Assessment



Deviation from Isotropy in Liquid

Error (ϕ, θ), f = 900 MHz



Appendix: Modulation Calibration Parameters

UID	Rev	Communication System Name	Group	PAR (dB)	Unc ^E k = 2
0		Continuous Wave	CW	0.00	±4.7
10010	CAB	Pulse (D=10%, T=100 ms)	Test	10.00	±9.6
10011	CAC	Rel. 99, RMC, QPSK, 5.0 MHz	WCDMA	2.91	±9.6
10012	CAB	DSSS, DBPSK, 1.0 Mbps, 92.5% DC	WLAN	1.87	±9.6
10013	CAB	OFDM, BPSK, 6.0 Mbps, 72.1% DC	WLAN	9.46	±9.6
10021	DAC	Voice, GMSK, 1 slot(s)	GSM	9.39	±9.6
10023	DAC	Data, GMSK, 1 slot(s)	GSM	9.57	±9.6
10024	DAC	Data, GMSK, 2 slot(s)	GSM	6.56	±9.6
10025	DAC	Data, 8PSK, 1 slot(s)	GSM	12.62	±9.6
10026	DAC	Data, 8PSK, 2 slot(s)	GSM	9.55	±9.6
10027	DAC	Data, GMSK, 3 slot(s)	GSM	4.80	±9.6
10028	DAC	Data, GMSK, 4 slot(s)	GSM	3.55	±9.6
10029	DAC	Data, 8PSK, 3 slot(s)	GSM	7.78	±9.6
10030	CAA	BR, DH1, GFSK	Bluetooth	5.30	±9.6
10031	CAA	BR, DH3, GFSK	Bluetooth	1.87	±9.6
10032	CAA	BR, DH5, GFSK	Bluetooth	1.16	±9.6
10033	CAA	EDR, DH1, $\pi/4$ -DQPSK	Bluetooth	7.74	±9.6
10034	CAA	EDR, DH3, $\pi/4$ -DQPSK	Bluetooth	4.53	±9.6
10035	CAA	EDR, DH5, $\pi/4$ -DQPSK	Bluetooth	3.83	±9.6
10036	CAA	EDR, DH1, 8-DPSK	Bluetooth	8.01	±9.6
10037	CAA	EDR, DH3, 8-DPSK	Bluetooth	4.77	±9.6
10038	CAA	EDR, DH5, 8-DPSK	Bluetooth	4.10	±9.6
10039	CAB	RC1, 1xRTT	CDMA2000	4.57	±9.6
10048	CAA	Full Slot, GFSK, 1 slot(s)	DECT	13.80	±9.6
10049	CAA	Double Slot, GFSK, 2 slot(s)	DECT	10.79	±9.6
10056	CAA	TD-SCDMA, QPSK, 1.6 MHz	TD-SCDMA	11.01	±9.6
10058	DAC	Data, 8PSK, 4 slot(s)	GSM	6.52	±9.6
10059	CAB	DSSS, DQPSK, 2.0 Mbps, 87.4% DC	WLAN	2.12	±9.6
10060	CAB	HR-DSSS, DQPSK, 5.5 Mbps, 72.7% DC	WLAN	2.83	±9.6
10061	CAB	HR-DSSS, DQPSK, 11.0 Mbps, 57.5% DC	WLAN	3.60	±9.6
10062	CAE	OFDM, BPSK, 6.0 Mbps, 89.1% DC	WLAN	8.68	±9.6
10063	CAE	OFDM, BPSK, 9.0 Mbps, 85.3% DC	WLAN	8.63	±9.6
10064	CAE	OFDM, QPSK, 12.0 Mbps, 82.0% DC	WLAN	9.09	±9.6
10065	CAE	OFDM, QPSK, 18.0 Mbps, 76.0% DC	WLAN	9.00	±9.6
10066	CAE	OFDM, 16QAM, 24.0 Mbps, 70.6% DC	WLAN	9.38	±9.6
10067	CAE	OFDM, 16QAM, 36.0 Mbps, 62.9% DC	WLAN	10.12	±9.6
10068	CAE	OFDM, 64QAM, 48.0 Mbps, 56.6% DC	WLAN	10.24	±9.6
10069	CAE	OFDM, 64QAM, 54.0 Mbps, 54.4% DC	WLAN	10.56	±9.6
10071	CAB	OFDM, BPSK, 9.0 Mbps, 65.1% DC	WLAN	9.83	±9.6
10072	CAB	OFDM, QPSK, 12.0 Mbps, 60.1% DC	WLAN	9.62	±9.6
10073	CAB	OFDM, QPSK, 18.0 Mbps, 53.1% DC	WLAN	9.94	±9.6
10074	CAB	OFDM, 16QAM, 24.0 Mbps, 48.5% DC	WLAN	10.30	±9.6
10075	CAB	OFDM, 16QAM, 36.0 Mbps, 42.9% DC	WLAN	10.77	±9.6
10076	CAB	OFDM, 64QAM, 48.0 Mbps, 39.5% DC	WLAN	10.94	±9.6
10077	CAB	OFDM, 64QAM, 54.0 Mbps, 38.5% DC	WLAN	11.00	±9.6
10081	CAB	RC3, 1xRTT	CDMA2000	3.97	±9.6
10097	CAC	Rel. 5 HSDPA, QPSK, 5.0 MHz	WCDMA	3.98	±9.6
10098	CAC	Rel. 6 HSUPA, Subset 2, QPSK, 5.0 MHz	WCDMA	3.98	±9.6
10100	CAF	20.0 MHz, QPSK, 100% RB	LTE-FDD	5.67	±9.6
10101	CAF	20.0 MHz, 16QAM, 100% RB	LTE-FDD	6.42	±9.6
10102	CAF	20.0 MHz, 64QAM, 100% RB	LTE-FDD	6.60	±9.6
10103	CAH	20.0 MHz, QPSK, UL/DL CFG: 1, SSC: 4, 100% RB	LTE-TDD	9.29	±9.6
10104	CAH	20.0 MHz, 16QAM, UL/DL CFG: 1, SSC: 4, 100% RB	LTE-TDD	9.97	±9.6
10105	CAH	20.0 MHz, 64QAM, UL/DL CFG: 1, SSC: 4, 100% RB	LTE-TDD	10.01	±9.6
10108	CAH	10.0 MHz, QPSK, 100% RB	LTE-FDD	5.80	±9.6
10109	CAH	10.0 MHz, 16QAM, 100% RB	LTE-FDD	6.43	±9.6
10110	CAH	5.0 MHz, QPSK, 100% RB	LTE-FDD	5.75	±9.6
10111	CAH	5.0 MHz, 16QAM, 100% RB	LTE-FDD	6.44	±9.6
10112	CAH	10.0 MHz, 64QAM, 100% RB	LTE-FDD	6.59	±9.6
10113	CAH	5.0 MHz, 64QAM, 100% RB	LTE-FDD	6.62	±9.6
10114	CAE	HT40 Greenfield, MCS0 (13.5 Mbps), 99.7% DC	WLAN	8.10	±9.6
10115	CAE	HT40 Greenfield, MCS4 (81.0 Mbps), 99.7% DC	WLAN	8.46	±9.6
10116	CAE	HT40 Greenfield, MCS7 (135.0 Mbps), 99.7% DC	WLAN	8.15	±9.6